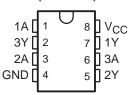
- **Available in the Texas Instruments** NanoStar™ and NanoFree™ Packages
- Supports 5-V V_{CC} Operation
- Inputs Accept Voltages to 5.5 V
- Max tpd of 4.1 ns at 3.3 V
- Low Power Consumption, 10-µA Max I_{CC}
- ±24-mA Output Drive at 3.3 V
- Typical V_{OI P} (Output Ground Bounce) <0.8 V at $V_{CC} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$
- Typical V_{OHV} (Output V_{OH} Undershoot) >2 V at V_{CC} = 3.3 V, T_A = 25°C
- **Ioff Supports Partial-Power-Down Mode** Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- **ESD Protection Exceeds JESD 22**
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)

DCT OR DCU PACKAGE (TOP VIEW)



YEA, YEP, YZA, OR YZP PACKAGE (BOTTOM VIEW)

GND	04	50	2Y
2A	○ 3	60	ЗА
3Y	02	70	1Y
GND 2A 3Y 1A	01	80	Vcc

description/ordering information

This triple inverter is designed for 1.65-V to 5.5-V V_{CC} operation. The SN74LVC3G04 performs the Boolean function Y = A.

ORDERING INFORMATION

TA	PACKAGE [†]	ORDERABLE PART NUMBER	TOP-SIDE MARKING [‡]	
	NanoStar™ – WCSP (DSBGA) 0.17-mm Small Bump – YEA		SN74LVC3G04YEAR	
-40°C to 85°C	NanoFree™ – WCSP (DSBGA) 0.17-mm Small Bump – YZA (Pb-free)	D 1 (0000	SN74LVC3G04YZAR	00
	NanoStar™ – WCSP (DSBGA) 0.23-mm Large Bump – YEP	Reel of 3000	SN74LVC3G04YEPR	cc_
	NanoFree™ – WCSP (DSBGA) 0.23-mm Large Bump – YZP (Pb-free)		SN74LVC3G04YZPR	
	SSOP - DCT	Reel of 3000	SN74LVC3G04DCTR	C04
	VSSOP – DCU	Reel of 3000	SN74LVC3G04DCUR	C04
	V330F - D00	Reel of 250	SN74LVC3G04DCUT	C04_

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

DCT: The actual top-side marking has three additional characters that designate the year, month, and assembly/test site. DCU: The actual top-side marking has one additional character that designates the assembly/test site. YEA/YZA, YEP/YZP: The actual top-side marking has three preceding characters to denote year, month, and sequence code, and one following character to designate the assembly/test site. Pin 1 identifier indicates solder-bump composition $(1 = SnPb, \bullet = Pb-free).$



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ISTRUMENTS

SCES363H - AUGUST 2001 - REVISED SEPTEMBER 2003

description/ordering information (continued)

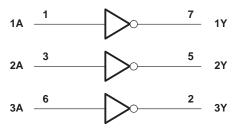
NanoStar™ and NanoFree™ package technology is a major breakthrough in IC packaging concepts, using the die as the package.

This device is fully specified for partial-power-down applications using Ioff. The Ioff circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

FUNCTION TABLE (each inverter)

INPUT A	OUTPUT Y
Н	L
L	Н

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage range, V_{CC}	
(see Note 1)	–0.5 V to 6.5 V
Voltage range applied to any output in the high or low state, VO	
(see Notes 1 and 2)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I_{IK} ($V_I < 0$)	–50 mA
Output clamp current, I _{OK} (V _O < 0)	
Continuous output current, IO	±50 mA
Continuous current through V _{CC} or GND	±100 mA
Package thermal impedance, θ _{JA} (see Note 3): DCT package	
DCU package	227°C/W
YEA/YZA package	
YEP/YZP package	
Storage temperature range, T _{stg}	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.
 - 2. The value of V_{CC} is provided in the recommended operating conditions table.
 - 3. The package thermal impedance is calculated in accordance with JESD 51-7.



SN74LVC3G04

recommended operating conditions (see Note 4)

			MIN	MAX	UNIT	
	Overalisans	Operating	1.65	5.5	V	
VCC	Supply voltage	Data retention only	1.5		V	
		V _{CC} = 1.65 V to 1.95 V	0.65 × V _{CC}			
V	High level input valte or	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7		.,	
V_{IH}	High-level input voltage	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$	2		V	
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	$0.7 \times V_{CC}$			
		V _{CC} = 1.65 V to 1.95 V		0.35 × V _{CC}		
V	Law lavel input valtage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.7	V	
V_{IL}	Low-level input voltage	V _{CC} = 3 V to 3.6 V		0.8	V	
		V _{CC} = 4.5 V to 5.5 V		$0.3 \times V_{CC}$		
VI	Input voltage		0	5.5	V	
٧o	Output voltage		0	VCC	V	
		V _{CC} = 1.65 V		-4		
		V _{CC} = 2.3 V		-8	1	
lOH	High-level output current	v		-16	mA	
		VCC = 3 V		-24		
		V _{CC} = 4.5 V		-32		
		V _{CC} = 1.65 V		4		
		V _{CC} = 2.3 V		8		
loL	Low-level output current			16	mA	
_		VCC = 3 V		24		
		V _{CC} = 4.5 V		ı		
		V _{CC} = 1.8 V ± 0.15 V, 2.5 V ± 0.2 V		20		
Δt/Δν	Input transition rise or fall rate	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		10		
		V _{CC} = 5 V ± 0.5 V		5		
TA	Operating free-air temperature	•	-40	85	°C	

NOTE 4: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

SCES363H - AUGUST 2001 - REVISED SEPTEMBER 2003

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARA	METER	TEST CO	NDITIONS	V _{CC}	MIN	TYP [†]	MAX	UNIT
		$I_{OH} = -100 \mu A$		1.65 V to 5.5 V	V _{CC} -0.1			
		$I_{OH} = -4 \text{ mA}$	1.65 V	1.2				
		$I_{OH} = -8 \text{ mA}$	2.3 V	1.9				
Vон		$I_{OH} = -16 \text{ mA}$		2.4			V	
		$I_{OH} = -24 \text{ mA}$	3 V	2.3				
		I _{OH} = -32 mA	4.5 V	3.8				
		I _{OL} = 100 μA		1.65 V to 5.5 V			0.1	
		$I_{OL} = 4 \text{ mA}$	1.65 V			0.45		
		$I_{OL} = 8 \text{ mA}$	2.3 V			0.3		
VOL		I _{OL} = 16 mA	0.1/			0.4	V	
		$I_{OL} = 24 \text{ mA}$	3 V			0.55		
		I _{OL} = 32 mA	4.5 V			0.55		
IĮ	A inputs	$V_I = 5.5 \text{ V or GND}$		0 to 5.5 V			±5	μΑ
l _{off}		V_I or $V_O = 5.5 V$		0			±10	μΑ
ICC		$V_I = 5.5 \text{ V or GND},$	I _O = 0	1.65 V to 5.5 V			10	μΑ
Δlcc		One input at V _{CC} – 0.6 V,	Other inputs at V _{CC} or GND	3 V to 5.5 V			500	μΑ
Ci		$V_I = V_{CC}$ or GND		3.3 V		3.5	·	pF

 $[\]dagger$ All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

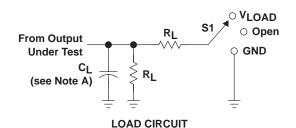
PARAMETER	FROM TO (OUTPUT)	_	V _{CC} = ± 0.1		V _{CC} =		V _{CC} =		V _{CC} =		UNIT
		(INFOT)	(001701)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX
t _{pd}	Α	Υ	3.2	7.9	1.5	4.4	1.4	4.1	1.1	3.2	ns

operating characteristics, $T_A = 25^{\circ}C$

PARAMETER		TEST COMPITIONS	V _{CC} = 1.8 V V _{CC} = 2.5		V _{CC} = 3.3 V	V _{CC} = 5 V	LINUT
		TEST CONDITIONS	TYP	TYP	TYP	TYP	UNIT
C _{pd}	Power dissipation capacitance	f = 10 MHz	16	16	16	18	pF

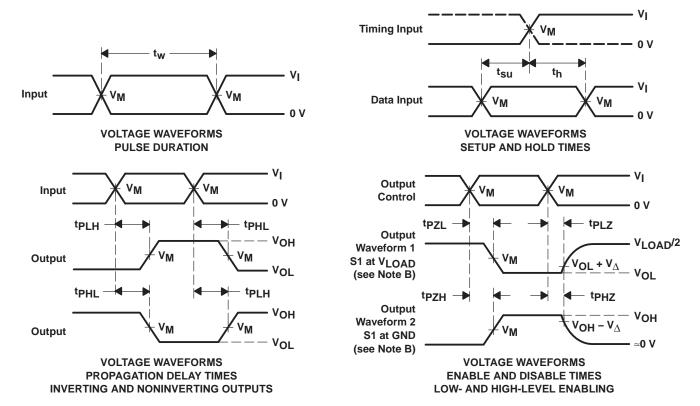


PARAMETER MEASUREMENT INFORMATION



TEST	S1
tPLH/tPHL	Open
tPLZ/tPZL	VLOAD
^t PHZ ^{/t} PZH	GND

Wa a	INPUTS			V	0.	В.	V
Vcc	٧ı	t _r /t _f	VM	VLOAD	CL	RL	V_Δ
1.8 V \pm 0.15 V	VCC	≤2 ns	V _{CC} /2	2×V _{CC}	30 pF	1 k Ω	0.15 V
2.5 V \pm 0.2 V	VCC	≤2 ns	V _{CC} /2	2×V _{CC}	30 pF	500 Ω	0.15 V
3.3 V \pm 0.3 V	3 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V
5 V \pm 0.5 V	VCC	≤2.5 ns	V _{CC} /2	2×V _{CC}	50 pF	500 Ω	0.3 V



NOTES: A. C_L includes probe and jig capacitance.

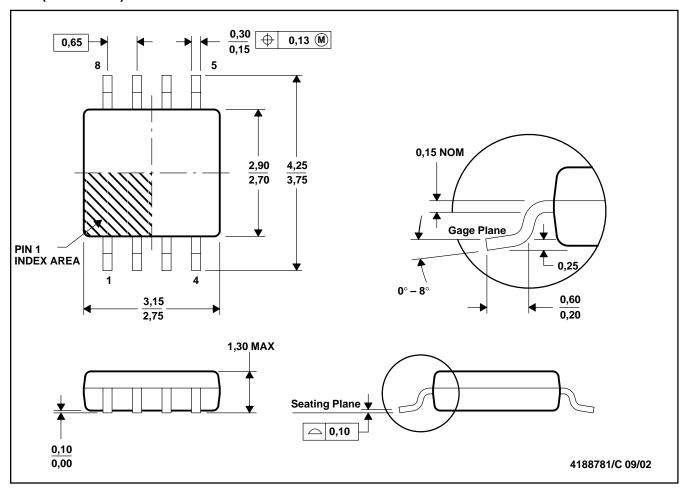
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_{O} = 50 \Omega$.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLZ and tpHZ are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.
- H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms



DCT (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE

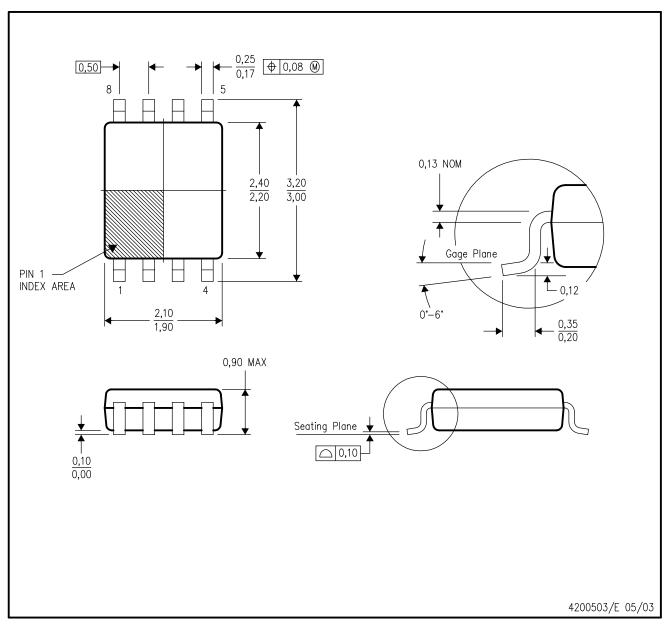


NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion
- D. Falls within JEDEC MO-187 variation DA.

DCU (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE (DIE DOWN)



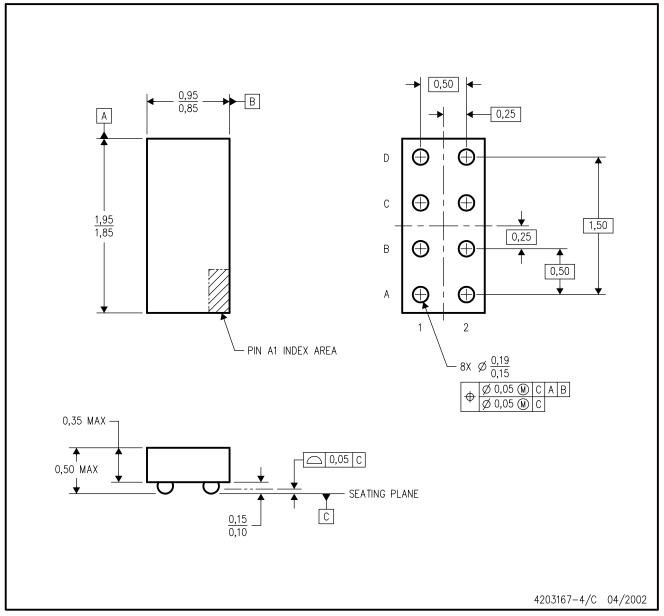
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion.
- D. Falls within JEDEC MO-187 variation CA.



YEA (R-XBGA-N8)

DIE-SIZE BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters.

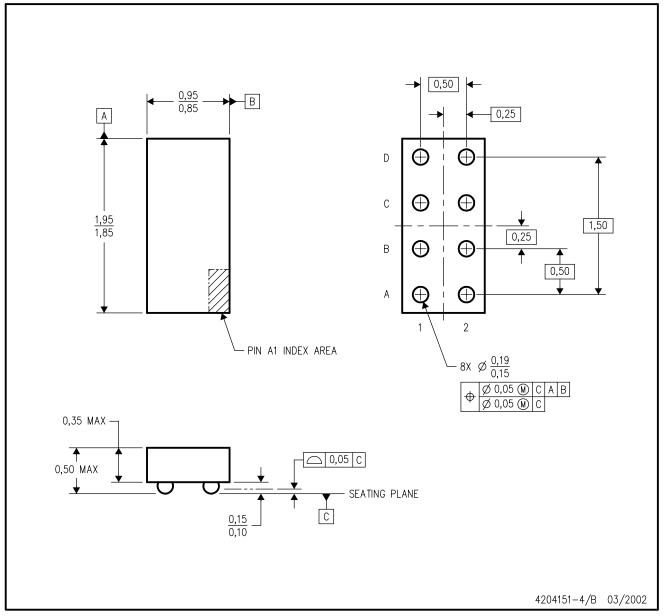
- B. This drawing is subject to change without notice.
- C. NanoStar \mathbf{M} package configuration.
- D. Package complies to JEDEC MO-211 variation EB.
- E. This package is tin-lead (SnPb). Refer to the 8 YZA package (drawing 4204151) for lead-free.

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YZA (R-XBGA-N8)

DIE-SIZE BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters.

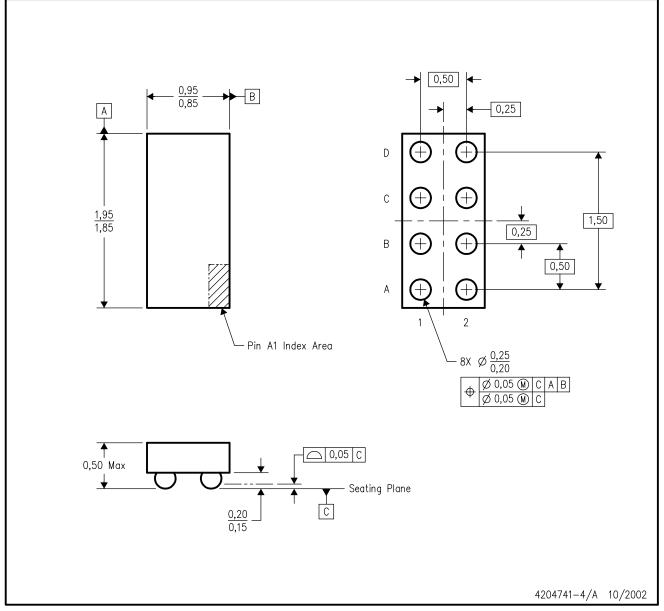
- B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.
- D. Package complies to JEDEC MO-211 variation EB.
- E. This package is lead-free. Refer to the 8 YEA package (drawing 4203167) for tin-lead (SnPb).

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YZP (R-XBGA-N8)

DIE-SIZE BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters.

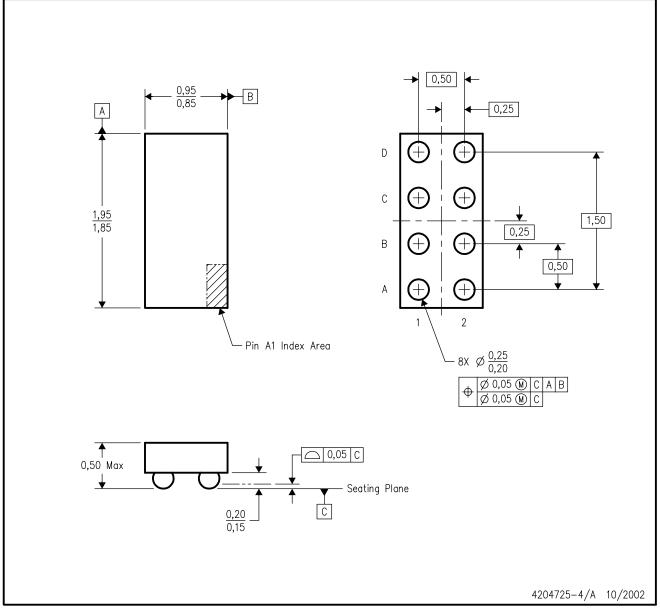
- B. This drawing is subject to change without notice.
- C. NanoFree $^{\text{TM}}$ package configuration.
- D. This package is lead-free. Refer to the 8 YEP package (drawing 4204725) for tin-lead (SnPb).

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YEP (R-XBGA-N8)

DIE-SIZE BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. NanoStar \mathbf{M} package configuration.
- D. This package is tin-lead (SnPb). Refer to the 8 YZP package (drawing 4204741) for lead-free.

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